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IN THE UNITED STATES PATENT AND TRADEMARK OFFICE

IN RE APPLICATION OF: Andrej S. MITROVIC

SERIAL NO: 10/673,583

GAU: 2812

FILED: September 30, 2003

EXAMINER: SAXENA, AKASH

FOR: SYSTEM AND METHOD FOR USING FIRST-PRINCIPLES SIMULATION TO PROVIDE VIRTUAL SENSORS
THAT FACILITATE A SEMICONDUCTOR MANUFACTURING PROCESS

INFORMATION DISCLOSURE STATEMENT UNDER 37 CFR 1.97

COMMISSIONER FOR PATENTS
ALEXANDRIA, VIRGINIA 22313

SIR:

Applicant(s) wish to disclose the following information.

REFERENCES

The applicant(s) wish to make of record the references cited on the attached PTO-1449 and the attached International Search Report dated September 1, 2005, filed along with the PCT Written Opinion. Copies of the listed references are attached, where required, as are either statements of relevancy or any readily available English translations of pertinent portions of any non-English language references.

A check or credit card payment form is attached in the amount required under 37 CFR §1.17(p).

RELATED CASES

Attached is a list of applicant's pending application(s), published application(s) or issued patent(s) which may be related to the present application. In accordance with the waiver of 37 CFR 1.98 dated September 21, 2004, copies of the cited pending applications are not provided. Cited published and/or issued patents, if any, are listed on the attached PTO form 1449.

A check or credit card payment form is attached in the amount required under 37 CFR §1.17(p).

CERTIFICATION

Each item of information contained in this information disclosure statement was first cited in any communication from a foreign patent office in a counterpart foreign application not more than three months prior to the filing of this statement.

No item of information contained in this information disclosure statement was cited in a communication from a foreign patent office in a counterpart foreign application or, to the knowledge of the undersigned, having made reasonable inquiry, was known to any individual designated in 37 CFR §1.56(c) more than three months prior to the filing of this statement.

DEPOSIT ACCOUNT

Please charge any additional fees for the papers being filed herewith and for which no check or credit card payment is enclosed herewith, or credit any overpayment to deposit account number 15-0030. A duplicate copy of this sheet is enclosed.

Respectfully submitted,

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Form PTO 1448 (Modified)		U.S. DEPARTMENT OF COMMERCE PATENT AND TRADEMARK OFFICE		ATTY DOCKET NO. 230420US6YA	SERIAL NO. 10/673,583		
<p>LIST OF REFERENCES CITED BY APPLICANT</p> <p>SEP 15 2003</p> <p>U.S. PATENT & TRADEMARK OFFICE</p>		APPLICANT Andrej S. MITROVIC					
		FILING DATE September 30, 2003		GROUP 2812			
		U.S. PATENT DOCUMENTS					
EXAMINER INITIAL		DOCUMENT NUMBER	DATE	NAME	CLASS	SUB CLASS	FILING DATE IF APPROPRIATE
/AS/	AA	US 5,719,796	02/17/1998	Chen			
	AB	US 5,539,652	07/23/1996	Tegethoff			
	AC	US 2004/0102934	05/27/04	Chang			
	AD	US 6,615,097 B2	09/02/03	Ozaki			
	AE	US 6,581,029 B1	06/17/03	Fisher			
/AS/	AF	US 6,802,045 B1	10/05/04	Sonderman, et al.			
	AG						
	AH						
	AI						
	AJ						
	AK						
	AL						
	AM						
	AN						
FOREIGN PATENT DOCUMENTS							
		DOCUMENT NUMBER	DATE	COUNTRY	TRANSLATION		
	AO				YES	NO	
	AP						
	AQ						
	AR						
	AS						
	AT						
	AU						
	AV						
OTHER REFERENCES (Including Author, Title, Date, Pertinent Pages, etc.)							
	AW						
	AX						
	AY						
	AZ	<input type="checkbox"/> Additional References sheet(s) attached					
Examiner /Akash Saxena/ (03/26/2007)					Date Considered		

*Examiner: Initial if reference is considered, whether or not citation is in conformance with MPEP 609; Draw line through citation if not in conformance and not considered. Include copy of this form with next communication to applicant.